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| Notic of References Cited | Application/Control No. 09/886,654 | Applicant(s)/Patent Under Reexamination ZAJAC ET AL. | |
| | Examiner Kin-Chan Chen | Art Unit 1765 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-5,581,874 | 12-1996 | Aoki et al. | 29/825 |
| | B | US-5,888,907 | 03-1999 | Tomoyasu et al. | 438/714 |
| | C | US-6,451,157 | 09-2002 | Hubacek, Jerome | 438/706 |
| | D | US-6,091,217 | 07-2000 | Parsadayan, Walter | 318/285 |
| | E | US-5,593,511 | 01-1997 | Foster et al. | 148/238 |
| | F | US-5,212,116 | 05-1993 | Yu, Chen-Hua D. | 438/697 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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